## Applicant(s)/Patent Under Application/Control No. Reexamination 10/601,034 GOODMAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2141 Djenane M. Bayard **U.S. PATENT DOCUMENTS** Date Document Number Classification Name Country Code-Number-Kind Code MM-YYYY 10-2004 709/206 US-2004/0199585 Wang, Bing Α US-В С US-US-D US-E US-F US-G US-Н US-

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